

Search Notes

Application/Control No.

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Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

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Art Unit

2634

SEARCHED

Class	Subclass	Date	Examiner
327	164	6/23/2005	EMF
370	203	6/23/2005	EMF
375	130	6/23/2005	EMF
375	260	6/23/2005	EMF
375	285	6/23/2005	EMF
375	343	6/23/2005	EMF
375	367	6/23/2005	EMF
455	42-45	6/23/2005	EMF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM	6/23/2005	EMF
PALM INVENTORSHIP	6/23/2005	EMF
IEEE Keyword Search	6/23/2005	EMF